Searcl	h Not	es

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/717,268	BRCKA ET AL.	
Examiner	Art Unit	
Bakoch K Dhinara	1763	

SEARCHED			
Class	Subclass	Date	Examiner
118	726	1/31/2006	RD
118	723	1/31/2006	RD
156	345.44	1/31/2006	RD
<u> </u>	Seere	h Update	2)

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		<u> </u>	<del> </del>	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Image and text search in East	1/31/2006	RD	
Inventor and assignee search in East	2/1/2006	RD	
Foreign search in East	2/1/2006 1.	RD	
Search Updated	ンプ		
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